

<b>Notice of References Cited</b>	Application/Control No. 10/821,695		Applicant(s)/Patent Under Reexamination SEVER ET AL.	
	Examiner Mark L. Berch		Art Unit 1624	Page 1 of 2

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0059818	03-2005	Duerst et al.	540/222
*	B	US-6,350,869	02-2002	Sturm et al.	540/220
*	C	US-6,093,814	07-2000	Lee et al.	540/222
*	D	US-2005/0080255 A1	04-2005	Kumar et al.	540/222
*	E	US-2006/0040915	02-2006	Kumar et al.	514/202
*	F	US-2003/0204082 A1	10-2003	Manca et al.	540/222
*	G	US-2004/0210049 A1	10-2004	Lee et al.	540/222
*	H	US-2004/0242556 A1	12-2004	Dandala et al.	514/202
*	I	US-2004/0242557 A1	12-2004	Dandala et al.	514/202
*	J	US-2005/0137182 A1	06-2005	Dandala et al.	514/202
*	K	US-6,878,827 B2	04-2005	Ono et al.	548/194
*	L	US-4,559,334	12-1985	Takaya et al.	514/202
*	M	US-4,935,507	06-1990	Takaya et al.	540/222

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 9955710 A1	11-1999	World Intellect	VAN et al.	
	O	WO 2004046154 A1	06-2004	World Intellect	DESHPANDE et al.	
	P					
	Q	JP 02000790 A2	01-1990	World Intellect	SAKANE et al	---
	R	WO 2006008160 A1	01-2006	World Intellect	KREMMINGER et al.	
	S	WO 1079211 A1	01-2001	World Intellect	KAMEYAMA, et al	C07D501/22
	T	WO2006006040 A1	01-2006	WIPO	ANDREW, G et al.	

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Maritza González, Il Farmaco, Volume 58, Issue 6, June 2003, Pages 409-418
	V	Lin, Hecheng Huaxue 9(5) 383-385 2001 and translation
	W	Sakane, Yakugaku Zasshi 113(9) 605-26 1993 and partial translation.
	X	Inamoto, J. Antibiotics 41, 828 (1988)

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/821,695		Applicant(s)/Patent Under Reexamination SEVER ET AL.	
	Examiner Mark L. Berch		Art Unit 1624	Page 2 of 2

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0209451	09-2005	Manca et al.	540/222
*	B	US-2005/0245738	11-2005	Singh et al.	540/222
*	C	US-2005/0215781	09-2005	Chandrasekaran et al.	540/222
*	D	US-2005/0209211	09-2005	Law et al.	514/202
*	E	US-2006/0029674 A1	02-2006	Sever et al.	424/486
*	F	US-2006/0025586 A1	02-2006	Kremming et al.	540/222
*	G	US-2004/0210049 A1	10-2004	Lee et al.	540/222
*	H	US-2005/0113355	05-2005	Duerst et al.	514/202
*	I	US-2005/0059819	03-2005	Duerst et al.	540/222
*	J	US-4,585,860	04-1986	Takaya et al.	514/202
*	K	US-2006/0074236	04-2006	Pozzi et al.	540/222
*	L	US-6,423,341	07-2002	Yamaguchi, Hisami	424/465
*	M	US-6,369,050	04-2002	Matsumoto et al.	514/210.05

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 1609793 A1	12-2005	European Patent	IMAI et al.	
	O	EP 1273587 A1	01-2003	European Patent	KAMEYAMA et al.	
	P	WO 2004104010 A1	12-2004	World Intellect	KUMAR et al.	
	Q	WO 2004056835 A1	07-2004	World Intellect	POZZI et al.	
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.